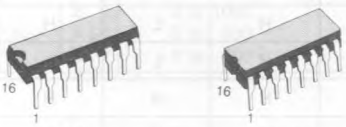
SGS-THOMSON MICROELECTRONICS

M54HC109
M74HC109

DUAL J-$\overline{K}$ FLIP FLOP WITH PRESET AND CLEAR

- HIGH SPEED
  f_{MAX} = 60 MHz (TYP.) at V_{CC} = 5V
- LOW POWER DISSIPATION
  I_{CC} = 2 μA (MAX.) at T_A = 25°C
- HIGH NOISE IMMUNITY
  V_{NIH} = V_{NIL} = 28% V_{CC} (MIN.)
- OUTPUT DRIVE CAPABILITY
  10 LSTTL LOADS
- SYMMETRICAL OUTPUT IMPEDANCE
  $|I_{OH}|$ = I_{OL} = 4 mA (MIN.)
- BALANCED PROPAGATION DELAYS
  t_{PLH} = t_{PHL}
- WIDE OPERATING VOLTAGE RANGE
  V_{CC} (OPR) = 2V to 6V
- PIN AND FUNCTION COMPATIBLE
  WITH 54/74LS109



B1N
Plastic Package

F1
Ceramic Frit Seal Package

M1
Micro Package

C1
Plastic Chip Carrier

ORDERING NUMBERS:

M54HC109 F1
M74HC109 B1N
M74HC109 F1
M74HC109 C1
M74HC109 M1

DESCRIPTION

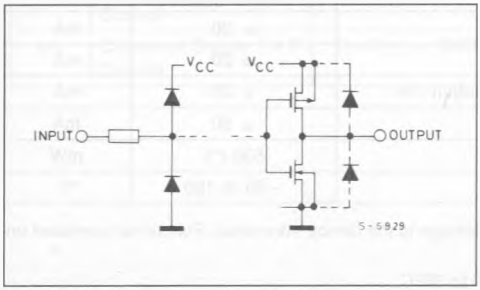
The M54/74HC109 is a high speed CMOS DUAL J-$\overline{K}$ FLIP-FLOP WITH PRESET AND CLEAR fabricated in silicon gate C²MOS technology.

It has the same high speed performance of LSTTL combined with true CMOS low power consumption.

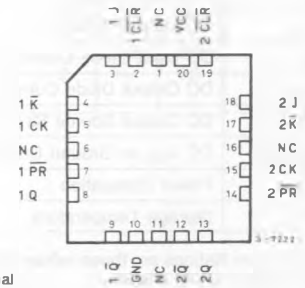
In accordance with the logic level on the J and $\overline{K}$ input is device changes state on positive going transitions of the clock pulse. CLEAR and PRESET are independent of the clock and accomplished by a low logic level on the corrisponding input.

All inputs are equipped with protection circuits against static discharge and transient excess voltage.

INPUT AND OUTPUT EQUIVALENT CIRCUIT



PIN CONNECTIONS (top view)



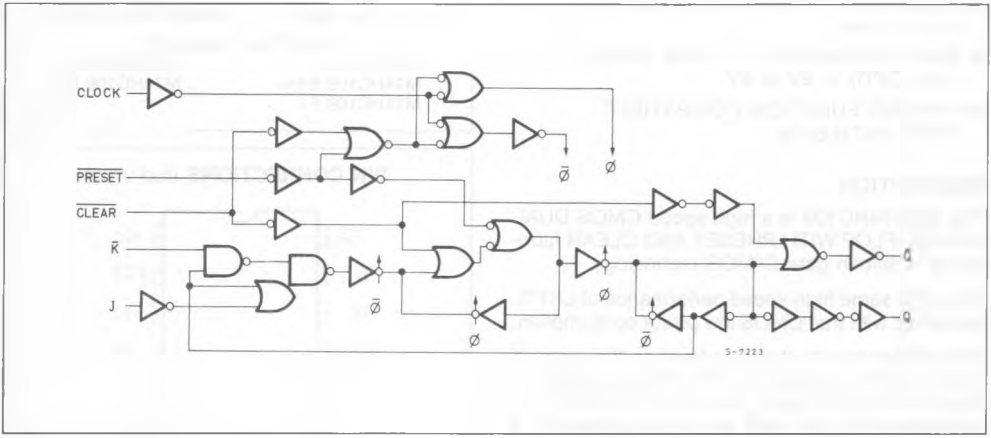
NC =
No Internal
Connection

TRUTH TABLE

INPUTS					OUTPUTS		FUNCTION
$\overline{CLR}$	$\overline{PR}$	J	$\overline{K}$	CK	Q	$\overline{Q}$	
L	H	X	X	X	L	H	CLEAR
H	L	X	X	X	H	L	PRESET
L	L	X	X	X	H	H	
H	H	L	H	↑	Qn	$\overline{Qn}$	NO CHANGE
H	H	L	L	↑	L	H	
H	H	H	H	↑	H	L	
H	H	H	L	↑	$\overline{Qn}$	Qn	TOGGLE
H	H	X	X	↓	Qn	$\overline{Qn}$	NO CHANGE

X: DON'T CARE

LOGIC DIAGRAM (1/2 package)



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	−0.5 to 7	V
V_I	DC Input Voltage	−0.5 to V_{CC} + 0.5	V
V_O	DC Output Voltage	−0.5 to V_{CC} + 0.5	V
I_{IK}	DC Input Diode Current	± 20	mA
I_{OK}	DC Output Diode Current	± 20	mA
I_O	DC Output Source Sink Current Per Output Pin	± 25	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	± 50	mA
P_D	Power Dissipation	500 (*)	mW
T_{stg}	Storage Temperature	−65 to 150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(*) 500 mW: ≅65°C derate to 300 mW by 10 mW/°C: 65°C to 85°C

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	2 to 6	V
V_I	Input Voltage	0 to V_{CC}	V
V_O	Output Voltage	0 to V_{CC}	V
T_A	Operating Temperature 74HC Series 54HC Series	− 40 to 85 −55 to 125	°C
t_r, t_f	Input Rise and Fall Time	V_{CC} = 2 V: 0 to 1000 V_{CC} = 4.5V: 0 to 500 V_{CC} = 6 V: 0 to 400	ns

DC SPECIFICATIONS

Symbol	Parameter	V_{CC}	Test Condition		T_A = 25°C 54HC and 74HC			−40 to 85°C 74HC		−55 to 125°C 54HC		Unit
			V_I	I_O	Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
V_{IH}	High Level Input Voltage	2.0			1.5	—	—	1.5	—	1.5	—	V
		4.5			3.15	—	—	3.15	—	3.15	—	
		6.0			4.2	—	—	4.2	—	4.2	—	
V_{IL}	Low Level Input Voltage	2.0			—	—	0.5	—	0.5	—	0.5	V
		4.5			—	—	1.35	—	1.35	—	1.35	
		6.0			—	—	1.8	—	1.8	—	1.8	
V_{OH}	High Level Output Voltage	2.0	V_{IH} or V_{IL}	−20 μA	1.9	2.0	—	1.9	—	1.9	—	V
		4.5			4.4	4.5	—	4.4	—	4.4	—	
		6.0			5.9	6.0	—	5.9	—	5.9	—	
		4.5		−4.0 mA	4.18	4.31	—	4.13	—	4.10	—	
		6.0		−5.2 mA	5.68	5.8	—	5.63	—	5.60	—	
V_{OL}	Low Level Output Voltage	2.0	V_{IH} or V_{IL}	20 μA	—	0	0.1	—	0.1	—	0.1	V
		4.5			—	0	0.1	—	0.1	—	0.1	
		6.0			—	0	0.1	—	0.1	—	0.1	
		4.5		4.0 mA	—	0.17	0.26	—	0.33	—	0.40	
		6.0		5.2 mA	—	0.18	0.26	—	0.33	—	0.40	
I_I	Input Leakage Current	6.0	V_I = V_{CC} or GND		—	—	±0.1	—	±1	—	±1	μA
I_{CC}	Quiescent Supply Current	6.0	V_I = V_{CC} or GND		—	—	2	—	20	—	40	μA

AC ELECTRICAL CHARACTERISTICS (V_{CC} = 5V, T_A = 25°C, C_L = 15pF, Input $t_r = t_f$ = 6ns)

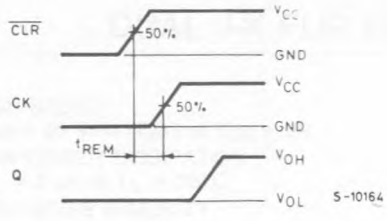
Symbol	Parameter	54HC and 74HC			Unit
		Min.	Typ.	Max.	
t_{TLH} t_{THL}	Output Transition Time		4	8	ns
t_{PLH} t_{PHL}	Propagation Delay Time (CLOCK-Q, $\overline{Q}$)		18	29	ns
t_{PLH} t_{PHL}	Propagation Delay Time ($\overline{CLR}$-Q, $\overline{PR}$-Q, $\overline{Q}$)		21	33	ns
f_{MAX}	Maximum Clock Frequency	33	63		MHz

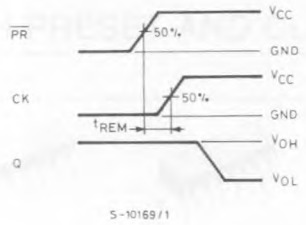
AC ELECTRICAL CHARACTERISTICS (C_L = 50pF, Input $t_r = t_f$ = 6ns)

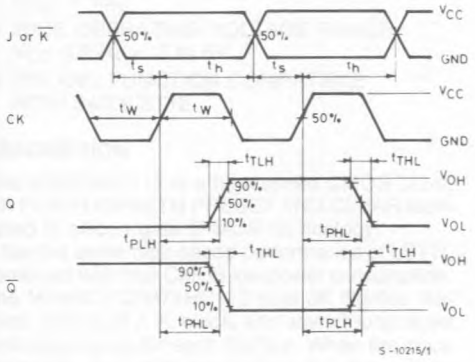
Symbol	Parameter	V_{CC}	Test Condition	T_A = 25°C 54HC and 74HC			−40 to 85°C 74HC		−55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t_{TLH} T_{THL}	Output Transition Time	2.0 4.5 6.0		— — —	30 8 7	75 15 13	— — —	95 19 16	— — —	110 22 19	ns
t_{PLH} t_{PHL}	Propagation Delay Time (CLOCK-Q, $\overline{Q}$)	2.0 4.5 6.0		— — —	80 21 18	165 33 28	— — —	205 41 35	— — —	250 50 43	ns
t_{PLH} t_{PHL}	Propagation Delay Time ($\overline{CLR}$, $\overline{PR}$-Q, $\overline{Q}$)	2.0 4.5 6.0		— — —	90 24 21	190 38 32	— — —	240 48 41	— — —	285 57 48	ns
f_{MAX}	Maximum Clock Frequency	2.0 4.5 6.0		6 30 35	15 57 67	— — —	4.8 24 28	— — —	4 20 28	— — —	MHz
$t_{W(L)}$ $t_{W(H)}$	Minimum Pulse Width (CLOCK)	2.0 4.5 6.0		— — —	30 8 7	75 15 13	— — —	95 19 16	— — —	110 22 19	ns
$t_{W(L)}$	Minimum Pulse Width ($\overline{CLR}$, $\overline{PR}$)	2.0 4.5 6.0		— — —	30 8 7	75 15 13	— — —	95 19 16	— — —	110 22 19	ns
t_s	Minimum Set-Up Time	2.0 4.5 6.0		— — —	30 8 7	75 15 13	— — —	95 19 16	— — —	110 22 19	ns
t_h	Minimum Hold Time	2.0 4.5 6.0		— — —	— — —	0 0 0	— — —	0 0 0	— — —	0 0 0	ns
t_{REM}	Minimum Removal Time ($\overline{CLR}$, $\overline{PR}$)	2.0 4.5 6.0		— — —	40 10 9	100 20 17	— — —	125 25 21	— — —	150 30 26	ns
C_{IN}	Input Capacitance			—	5	10	—	10	—	10	pF
C_{PD} (*)	Power Dissipation Capacitance			—	47	—	—	—	—	—	pF

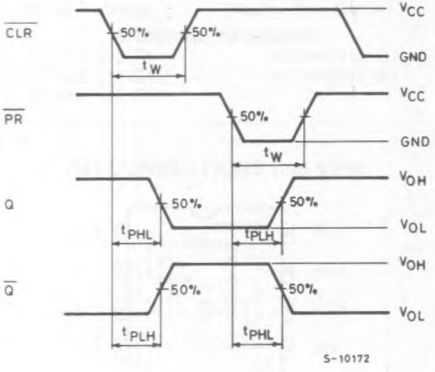
Note (*) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit)
Average operating current can be obtained by the following equation I_{CC} (Opr.) = $C_{PD} \cdot V_{CC} \cdot f_{IN} \cdot I_{CC}/2$ (per FF)

SWITCHING CHARACTERISTICS TEST WAVEFORM

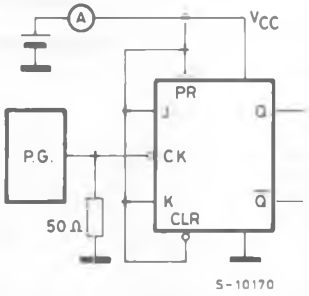








TEST CIRCUIT I_{CC} (Opr.)



INPUT WAVEFORM IS THE SAME AS THAT IN CASE OF SWITCHING CHARACTERISTICS TEST.